HIOKI

INSULATION TESTER ST5520



Industry's Fastest Testing Speed

Speeds

Unmatched Industry-beating test time Rapidly assess in as fast as 50 ms

High-speed auto discharge function Quick discharge of residual voltage

features poor contact

Prevents errors due to

Outstanding Contact check function Freely configurable test voltage Set from 25 V to 1000 V (1 V resolution)

Short-circuit check function Stops potential defects from reaching the market

Unmatched Speeds

Industry's Fastest Testing Speed

HIGH	HIOKI ST5520-01 INSULATION TESTER 100V 2000MΩ FAST 01 PANEL_01 V MONI 100V AUTO SHORT CHECK 0,000s
LOW EXT. SW	TIMER 1230 MΩ PASS UPPER LOWER LOWER 1300 MΩ 1000 MΩ FAIL SET VOLT COMP
	MENU F1 F2 F3 F4

The Insulation Tester ST5520 delivers the fastest insulation resistance testing in the industry, meeting all the requirements of production lines thanks to rapid takt times.

Industry-beating test time

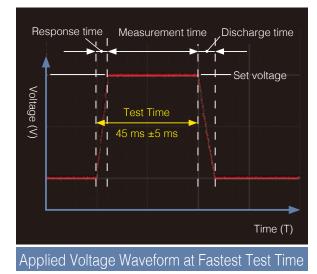
Rapidly assess in as fast as 50 ms

Testing is complete in as little as 50 ms the fastest time in the industry. This is 700 ms faster than legacy Hioki models.

 \star Discharge time varies according to the sample's capacitance

 \star The pictured waveform reflects use of a test time of 45 ms

 \star The waveform shows the test result for a 9 M Ω , 10 pF sample

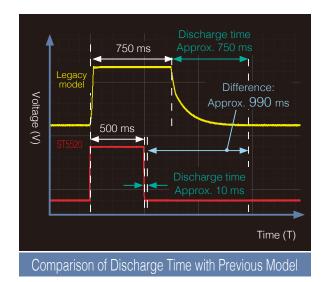


High-speed auto discharge function

Quickly discharge residual voltage

The post-test residual voltage discharge time has been reduced significantly compared with legacy models. As a result, when comparing an identical sample under the following conditions, a takt time improvement of 990 ms is estimated.

- ★ Discharge time varies according to the sample's capacitance
- \star The waveform shows the test result for a 9 MΩ, 10 pF sample



Outstanding features

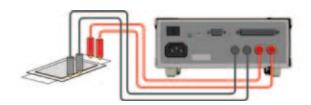
Contact check function

Prevents errors due to poor contact

The contact check function allows you to check that proper contact has been made with the device under test prior to the testing. This ensures that resistance testing is not carried out without proper contact, as this can result in erroneous assessment. There are two methods: 4-wire contact check and comparator contact check.

4-Wire Contact Check

Continuity between the low contact check terminal and the low output terminal, and between the high contact check terminal and the high output terminal, is verified.



Comparator Contact Check

If the comparator result exceeds a previously set upper limit after a normal connection, the instrument reports an "upper fail," indicating a contact failure.



Freely configurable test voltage

Configure from 25 V to 1000 V (1 V resolution)

In insulation resistance testing of lithiumion and other batteries, the specific test voltage used varies with the manufacturer. In addition, the test voltage for electronic components, such as relays and connectors, is likely to change in the future along with revisions to various standards. ST5520 allows the test voltage to be freely configured.



The test voltage can be changed simply by pressing the keys and verified on the screen.



With legacy models...

Legacy products provided a smaller number of choices, for example 25 V / 50 V /100 V / 250 V / 500 V / 1000 V.

25 V/50 V/100 V/250 V/500 V/1000 V

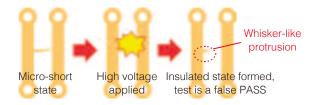


Short-circuit check function

Stops potential defects from reaching the market

With this function, a low voltage (2 V to 4 V DC) is applied to the test patterns to check for micro-shorting prior to insulation testing.

If insulation testing is performed incorrectly, remaining protrusions could cause issues after the product ships.



Comparator Function

Freely set upper and lower limit values

You can select from three types: upper limit, lower limit and upper-lower limit value assessment. Comparator operation can also be delayed for a certain period of time by specifying the preferred response time.



Switched Probe

Safe, easy operation at your fingertips

The use of optional Switched Probe 9299 lets you to operate the ST5520 while holding the probe.



Panel Save/Load Function

Saving and loading measurement condisions

Up to ten measurement conditions can be saved, and they are retained even if the power supply is off. The saved conditions can be loaded via key operation, RS-232C and EXT. I/O.

MEAS SYS PAN	EL I/0 IF	INFO			
01 PANEL_01	VOLTAGE	01007			
02 PANEL_02	RANGE	HOLD 2000Mg			
03 PANEL_03	SPEED	FAST			
04 PANEL_04	TIMER	ON 000.050s			
05 PANEL_05	DELAY	OFF			
06 PANEL_06	COMP U/L COMP MODE	600.0 /400.0MQ CONTINUE			
00	COMP BEEP	OFF			
US U com accr orr					
EXIT LOAD RENAME CLEAR SAVE					

External interfaces

Compatible with 38400 bps transmission speed

Built-in RS-232C interface

Use the RS-232C interface to capture measurement and assessment results from a PC, PLC or other system. The ST5520 is also equipped with a "data output function" for automatically sending the measurement values and assessment results at the end of each test.

	RS-232C Specifications
Transmission method	Communication method: Full duplex Synchronization method: Asynchronous
Transmission speed	9600 bps (default)/19200 bps/38400 bps
Data length	8-bit
Parity	N/A
Stop bit	1-bit
Message terminator (delimiter)	Receiving: CR+LF, CR/sending: CR+LF
Flow control	N/A
Electrical Specifications	Input voltage level 5 to 15 V: ON, -15 to -5 V: OFF Output voltage level 5 to 9 V: ON, -9 to -5 V: OFF
Connector	Interface connector pin arrangement (D-sub9 pin, male-type fixing screws #4-40) I/O connector specifications: terminal (DTE) Recommended cables: RS-232C Cable 9637 (for PC) RS-232C Cable 9638 (D-sub25 pin for connector)

Flexible support for control circuits

NPN / PNP switch

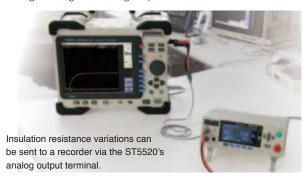
All signals are isolated using a photocoupler. (The input/ output common terminal is shared). The input circuit can be switched to support current sinking output (NPN) or current sourcing output (PNP) by configuring the switch.



Recording time variation

Analog output of measurement values

During testing, analog output is generated at the same timing as the instrument's measured value display. Once the test is complete, the instrument will continue to output the last voltage through its analog output terminal.



Output 0 to 4 V within full range of measurements [FULL]

Test voltage	Displayed resistance value	Output voltage (DC)
$25~V{\leq}V{<}100~V$	$0.000~\text{M}\Omega$ to 200.0 $\text{M}\Omega$	0 to 4 V
$100~V{\triangleq}V<500~V$	$0.000~M\Omega$ to 2000 $M\Omega$	0 to 4 V
$500 V \leq V \leq 1000 V$	$0.000~M\Omega$ to 4000 $M\Omega$	0 to 4 V
Full resistance range	Over.F	4 V
I un resistance range	Under.F	0 V

Output voltage according to each resistance range [EACH]

Resistance range	Displayed resistance value	Output voltage (DC)
2 MΩ	$0.000~M\Omega$ to $2.000~M\Omega$	0 to 4 V
20 ΜΩ	$1.90~\text{M}\Omega$ to $20.00~\text{M}\Omega$	0.38 to 4 V
200 ΜΩ	19.0 M Ω to 200.0 M Ω	0.38 to 4 V
2000 $M\Omega$ (100 to 499 V)	190 $M\Omega$ to 2000 $M\Omega$	0.38 to 4 V
4000 $M\Omega$ (500 to 1000 V)	190 $M\Omega$ to 4000 $M\Omega$	0.19 to 4 V
Full resistance range	Over.F	4 V
Full resistance range	Under.F	0 V

Also available with BCD output

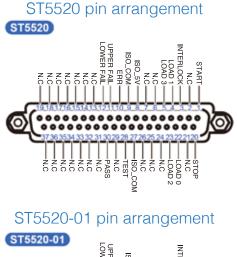
I/O terminals for external control

Control I/O signal no. table

ST5520/ST5520-01

Pin	Signal name	I/O	Function	Logic
1	START	IN	Start measurement	Edge
2	(Not used)	-	-	-
3	INTERLOCK	IN	Interlock	Level
4	LOAD1	IN	Select panel number	Level
5	LOAD3	IN	Select panel number	Level
6	(Not used)	-	-	-
8	ISO_5V	-	Isolated mains +5 V (-5 V) output	_
9	ISO_COM	-	Isolated mains common	-
10	ERR	OUT	Contact check error Short circuit check error Output voltage error	Level
11	UPPER FAIL	OUT	Comparator Assessment	Level
12	LOWER FAIL	OUT	Comparator Assessment	Level
20	STOP	IN	End measurement	Edge
21	(Not used)	-	-	-
22	LOAD0	IN	Select panel number	Level
23	LOAD2	IN	Select panel number	Level
27	ISO_COM	-	Isolated mains common	-
28	TEST	OUT	Measuring	Level
30	PASS	OUT	Comparator Assessment	Level

PinSignal nameI/OFunctionLogic7BCD0OUTBCDLevel13BCD1OUTBCDLevel14BCD2OUTBCDLevel15BCD3OUTBCDLevel16BCD4OUTBCDLevel17BCD5OUTBCDLevel18BCD6OUTBCDLevel19BCD7OUTBCDLevel24DP0OUTDecimal outputLevel25DP1OUTDecimal outputLevel26DP2OUTBCDLevel31BCD9OUTBCDLevel33BCD10OUTBCDLevel34BCD12OUTBCDLevel35BCD13OUTBCDLevel36BCD14OUTBCDLevel	ST5520-01 (BCD function)				
13BCD1OUTBCDLevel14BCD2OUTBCDLevel15BCD3OUTBCDLevel16BCD4OUTBCDLevel17BCD5OUTBCDLevel18BCD6OUTBCDLevel19BCD7OUTBCDLevel24DP0OUTDecimal outputLevel25DP1OUTDecimal outputLevel26DP2OUTBCDLevel31BCD9OUTBCDLevel33BCD10OUTBCDLevel34BCD12OUTBCDLevel35BCD13OUTBCDLevel	Pin	Signal name	I/O	Function	Logic
14BCD2OUTBCDLevel15BCD3OUTBCDLevel16BCD4OUTBCDLevel17BCD5OUTBCDLevel18BCD6OUTBCDLevel19BCD7OUTBCDLevel24DP0OUTDecimal outputLevel25DP1OUTDecimal outputLevel26DP2OUTBCDLevel31BCD9OUTBCDLevel33BCD10OUTBCDLevel34BCD12OUTBCDLevel35BCD13OUTBCDLevel	7	BCD0	OUT	BCD	Level
15BCD3OUTBCDLevel16BCD4OUTBCDLevel17BCD5OUTBCDLevel18BCD6OUTBCDLevel19BCD7OUTBCDLevel24DP0OUTDecimal outputLevel25DP1OUTDecimal outputLevel26DP2OUTDecimal outputLevel31BCD9OUTBCDLevel33BCD10OUTBCDLevel34BCD12OUTBCDLevel35BCD13OUTBCDLevel	13	BCD1	OUT	BCD	Level
16BCD4OUTBCDLevel17BCD5OUTBCDLevel18BCD6OUTBCDLevel19BCD7OUTBCDLevel24DP0OUTDecimal outputLevel25DP1OUTDecimal outputLevel26DP2OUTDecimal outputLevel31BCD9OUTBCDLevel33BCD10OUTBCDLevel34BCD12OUTBCDLevel35BCD13OUTBCDLevel	14	BCD2	OUT	BCD	Level
17BCD5OUTBCDLevel18BCD6OUTBCDLevel19BCD7OUTBCDLevel24DP0OUTDecimal outputLevel25DP1OUTDecimal outputLevel26DP2OUTDecimal outputLevel29BCD8OUTBCDLevel31BCD9OUTBCDLevel33BCD10OUTBCDLevel34BCD12OUTBCDLevel35BCD13OUTBCDLevel	15	BCD3	OUT	BCD	Level
18BCD6OUTBCDLevel19BCD7OUTBCDLevel24DP0OUTDecimal outputLevel25DP1OUTDecimal outputLevel26DP2OUTDecimal outputLevel29BCD8OUTBCDLevel31BCD9OUTBCDLevel32BCD10OUTBCDLevel33BCD11OUTBCDLevel34BCD12OUTBCDLevel35BCD13OUTBCDLevel	16	BCD4	OUT	BCD	Level
19BCD7OUTBCDLevel24DP0OUTDecimal outputLevel25DP1OUTDecimal outputLevel26DP2OUTDecimal outputLevel29BCD8OUTBCDLevel31BCD9OUTBCDLevel32BCD10OUTBCDLevel33BCD11OUTBCDLevel34BCD12OUTBCDLevel35BCD13OUTBCDLevel	17	BCD5	OUT	BCD	Level
24DP0OUTDecimal outputLevel25DP1OUTDecimal outputLevel26DP2OUTDecimal outputLevel29BCD8OUTBCDLevel31BCD9OUTBCDLevel32BCD10OUTBCDLevel33BCD11OUTBCDLevel34BCD12OUTBCDLevel35BCD13OUTBCDLevel	18	BCD6	OUT	BCD	Level
25DP1OUTDecimal outputLevel26DP2OUTDecimal outputLevel29BCD8OUTBCDLevel31BCD9OUTBCDLevel32BCD10OUTBCDLevel33BCD11OUTBCDLevel34BCD12OUTBCDLevel35BCD13OUTBCDLevel	19	BCD7	OUT	BCD	Level
26DP2OUTDecimal outputLevel29BCD8OUTBCDLevel31BCD9OUTBCDLevel32BCD10OUTBCDLevel33BCD11OUTBCDLevel34BCD12OUTBCDLevel35BCD13OUTBCDLevel	24	DP0	OUT	Decimal output	Level
29BCD8OUTBCDLevel31BCD9OUTBCDLevel32BCD10OUTBCDLevel33BCD11OUTBCDLevel34BCD12OUTBCDLevel35BCD13OUTBCDLevel	25	DP1	OUT	Decimal output	Level
31BCD9OUTBCDLevel32BCD10OUTBCDLevel33BCD11OUTBCDLevel34BCD12OUTBCDLevel35BCD13OUTBCDLevel	26	DP2	OUT	Decimal output	Level
32BCD10OUTBCDLevel33BCD11OUTBCDLevel34BCD12OUTBCDLevel35BCD13OUTBCDLevel	29	BCD8	OUT	BCD	Level
33BCD11OUTBCDLevel34BCD12OUTBCDLevel35BCD13OUTBCDLevel	31	BCD9	OUT	BCD	Level
34BCD12OUTBCDLevel35BCD13OUTBCDLevel	32	BCD10	OUT	BCD	Level
35 BCD13 OUT BCD Level	33	BCD11	OUT	BCD	Level
	34	BCD12	OUT	BCD	Level
36 BCD14 OUT BCD Level	35	BCD13	OUT	BCD	Level
	36	BCD14	OUT	BCD	Level
37 BCD15 OUT BCD Level	37	BCD15	OUT	BCD	Level

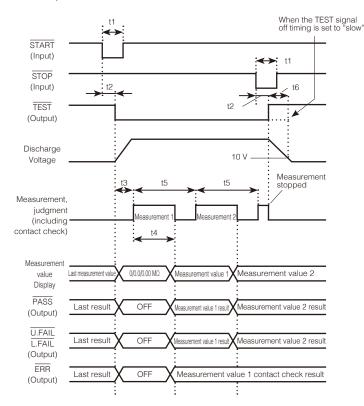


ST5520-01 NLC ST NLC ST

ST5520 timing chart

		Content	Time
t1	START, STOP signal pulse width		5 ms min.
t2	START, STO	P signal detection time	5 ms max.*
t3	Response tin	ne (DELAY)	AUTO, 5 ms to 999.9 s
t4	Measurement Contact check: OFF		30 ms (FAST), 480 ms (SLOW)
ι4	time	Contact check: ON	80 ms (FAST), 480 ms (SLOW)
t5	Measurement	Contact check: OFF	50 ms (FAST), 500 ms (SLOW)
15	interval	Contact check: ON	100 ms (FAST), 500 ms (SLOW)
t6	Discharge time (time until output voltage is 10 V or lower)		20 ms MAX. (When measuring pure resistance)*

*If the START signal is input after the test voltage is changed, the START signal detection time will increase by a maximum of 500 ms.



Checking the Control I/O Signal No. EXT. I/O Test & Monitoring Function

The output signal can be switched ON or OFF manually, and the output signal state can be viewed on-screen.

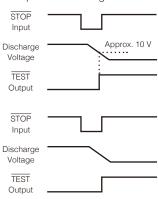
EXT I/0	TEST		I/0	TYPE :NPN
TEST	ERR	U.FAIL	PASS	LEAIL
DPO	DP1	DP2	BCDO	BCD1
BCD2	BCD3	BCD4	BCD5	BC06
BC07	BC08	BCD9	BCD10	BC011
BC012	BC013	BCD 14	BC015	
START	STOP		LOCK	
LOADO	LOAD 1	LOAD2	LOAD3	19. C
EXIT			ON	OFF

Checking and controlling voltage during discharge Setting the TEST signal OFF timing

You can choose between the following two settings to determine the timing at which the EXT I/O TEST signal output returns from low to high at the completion of testing:

[SLOW]: The low signal (the same as during testing) is maintained until the voltage of the device under test falls to about 10 V as a result of the operation of the discharge function.

[FAST]: The signal returns to high at about the same time as the test is completed.

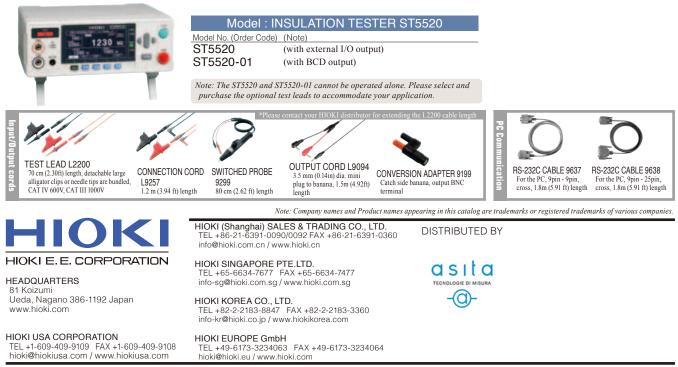


ST5520 Specifications (Accuracy guaranteed for 1 year, Post-adjustment accuracy guaranteed for 1 year)

Specifications				
Measurement items	Insulation resistance (DC voltage application method)	Dimensions	215 (8.46 in) W x 80 (3.15 in) H x 166 (6.54 in) D mm	
Output voltage	25 V to 1000 V (user-configurable), 1 V resolution		(excluding protruding parts)	
Sampling	FAST: 30 ms/time, SLOW: 500 ms/time (switch)	Mass	1.1 kg \pm 0.1 kg (38.8 oz \pm 3.5 oz)	
	Saved items: rated measurement voltage, comparator upper limit/lower limit values, test mode, beep sound to distinguish	Compliant Standards	Safety EN61010 EMC EN61326 Class A EN61000-3-2, EN61000-3-3	
Memory function	the result, test time, response time, resistance range, measurement speed Memory capacity: up to 10 items (can be saved/loaded)	Accessories	Instruction manual, power cord, EXT. I/O connector (male), connector cover (one of each)	
Test modes	Continuous mode, PASS STOP mode, FAIL STOP mode, force quit assessment mode (switchable)	Comparator Func		
Check function	Contact check function (ON/OFF) Short-circuit check function (ON/OFF)	Assessment	UPPER_FAIL, PASS, LOWER_FAIL, UL_FAIL UPPER_FAIL: Measured value ≥ upper limit value PASS: Upper limit value > measured value > lower limit value LOWER_FAIL: Measured value ≤ lower limit value	
Operating temperature / humidity range	0°C to 40°C, 80% rh or lower (non-condensing)		UL_FAIL: Unable to assess	
Storage temperature/ humidity range	-10°C to 50°C, 80% rh or lower (non-condensing)	Assessment Process	Beep sound, PASS/U.FAIL/L.FAIL light up on LED display When UL_FAIL, U.FAIL/L.FAIL light up simultaneously EXT. I/O output, assessment result can be obtained via	
Guaranteed accuracy temperature/humidity range	23°C \pm 5°C, 80% rh or lower (non-condensing)		RS-232C	
Usage location	Indoor use, pollution degree 2, up to a height of 2000 m	Test duration		
Detect course our elu			Test duration = Response time + Measurement time	
Rated power supply voltage	100 V AC to 240 V $\pm 10\%$	Function	Set the time from voltage application until pass/fail assessment	
Rated power supply		Configuration range	0.045 s to 999.999 s (0.001 s resolution)	
frequency	50/60 Hz	Response time tir	ner function	
Max. rated power	25 VA		The response time is the time during which comparator	
Withstand voltage	1.62 kV AC (sensed current 10 mA) 1 min Between power supply LN (together) and protective grounding terminal	Function	assessment operation is prohibited from the start of the test until the set response time has elapsed. No measurement values are displayed during the response time. The response time is included in the test time.	
Excessive input protection	1100 V DC (positive polarity only)	Configuration range	0.005 s to 999.999 s (0.001 s resolution)	

Measurement voltage/resistance range (can be switched between Auto Range/Manual Range)							
Rated measurement voltage	Popietanao rango	e Max. display Res	Resolution	Cuerenteed ecoureeu renge	Accuracy		
	Resistance range	wax. display	Resolution	Guaranteed accuracy range	FAST/SLOW		
	2 MΩ	4.000 MΩ	0.001 MΩ	0.000 MΩ to 2.000 MΩ	±2%rdg.±5dgt.		
$25 \text{ V} \le \text{V} \le 100 \text{ V}$	20 MΩ	40.00 MΩ	0.01 MΩ	1.90 MΩ to 20.00 MΩ	±2 /8/09.±309t.		
	200 MΩ	400.0 MΩ	0.1 MΩ	19.0 MΩ to 200.0 MΩ	±5%rdg.		
	2 MΩ	4.000 MΩ	0.001 MΩ	0.000 MΩ to 2.000 MΩ	±2%rdg.±5dgt.		
$100 V \le V \le 500 V$	20 MΩ	40.00 MΩ	0.01 MΩ	1.90 MΩ to 20.00 MΩ	±2 %rug.±3ugt.		
$100 \text{ v} \leq \text{v} < 500 \text{ v}$	200 MΩ	400.0 MΩ	0.1 MΩ	19.0 MΩ to 200.0 MΩ	±5%rdg.		
	2000 MΩ	4000 MΩ	1 MΩ*	19.0 MΩ to 2000 MΩ	±5%iug.		
	2 MΩ	4.000 MΩ	0.001 MΩ	0.000 MΩ to 2.000 MΩ			
$500~V \leq V \leq 1000V$	20 MΩ	40.00 MΩ	0.01 MΩ	1.90 MΩ to 20.00 MΩ	±2%rdg.±5dgt.		
	200 MΩ	400.0 MΩ	0.1 MΩ	19.0 MΩ to 200.0 MΩ			
	4000 MΩ	0000 MO	4000 MO 0000 MO	4000 ΜΩ 9990 ΜΩ 1 Μ	1 MΩ*	19.0 MΩ to 4000 MΩ	±5%rdg.
	4000 10122	9990 WI12	1 10122	4010 MΩ to 9990 MΩ	±25%rdg.		

*When displaying 1000 M Ω and above, resolution of 10 M Ω with rightmost digit set to 0



All information correct as of Feb. 1, 2018. All specifications are subject to change without notice.